## Search Notes

	Application No.	Applicant(s)
	10/041,957	TEIG ET AL.
	Examin r	Art Unit
_	Binh C. Tat	2825

		SEARCHED				
	Class	Subclass	Date	Examiner		
	716	1-=17	5/14/2004	ВТ		
	257	207-211	5/14/2004	ВТ		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
DATE		EXMR	1		
EAST SEARCH	5/14/2004	ВТ			
IEEE	5/14/2004	ВТ			
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